

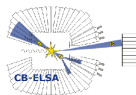
Tracking test bench for the GEM TPC

First results of data analysis

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8th of August 2009

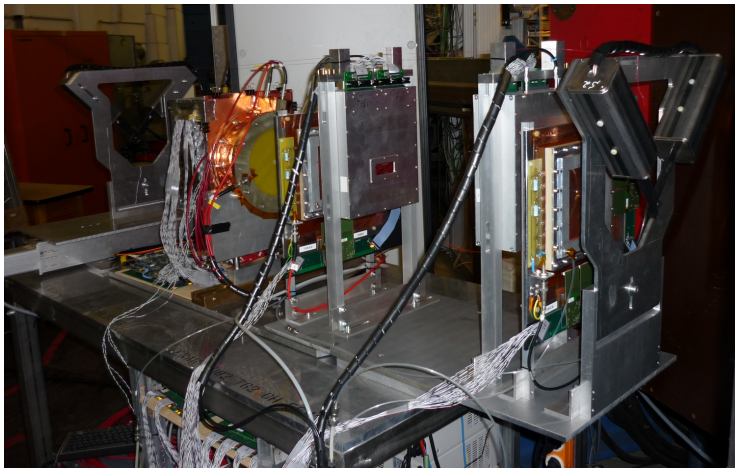


Aim of the tracking test bench

Aims and goals of the tracking test bench

- Test performance of a GEM TPC
- Investigate TPC components like FEE
- Develop and apply analysis software to real data
- Achieve experience in commissioning and operation of a TPC

Tracking test bench at ELSA in Bonn



Analysis of beam telescope data



Data processing chain

- Raw data decoding, error detection, data mapping

Analysis of beam telescope data



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- Clustering in 1 dimension

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- Generation of 2D hits per detector

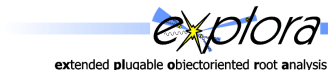
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Analysis of beam telescope data

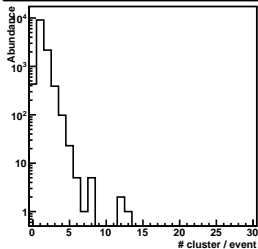


Data processing chain

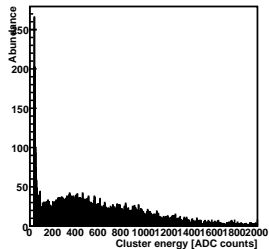
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- Clustering in 1 dimension
- Generation of 2D hits per detector
- Determination of 3D offsets (\rightarrow 3D hits)
- Track fitting, calculating residuals

1D Clustering

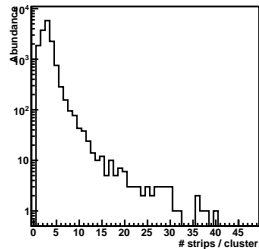
Number of Clusters per event (GEM1_x)



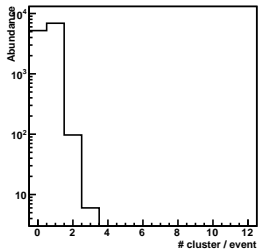
Cluster energy GEM1_x



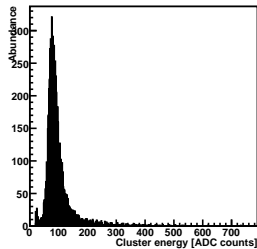
Strip counts GEM1_x



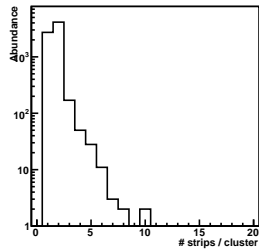
Number of Clusters per event (Si11_x)



Cluster energy Si11_x

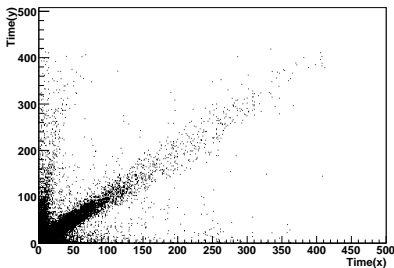


Strip counts Si11_x

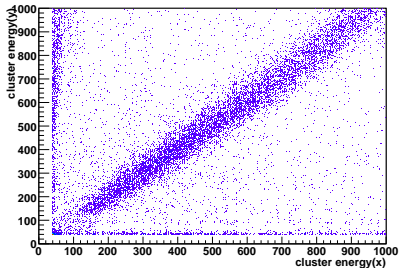


2D hit matching

Time correlation



Amplitude Correlation



Matching methods:

- Combinatorial
- Amplitude (GEM)
- Time (GEM & Sil)

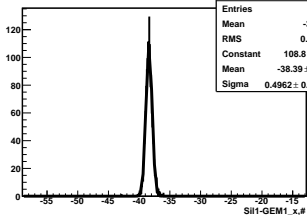
Goals:

- Get rid of noise
- Find real hits

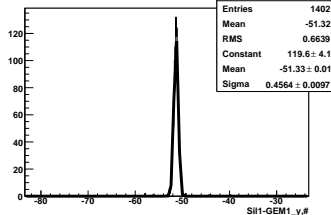
3D detector offsets

Determine x and y offsets by plotting $\text{det1}_x - \text{det2}_x \dots$

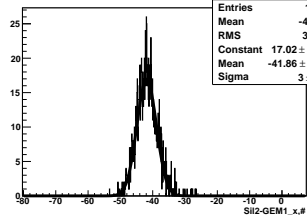
Sii1-GEM1_x



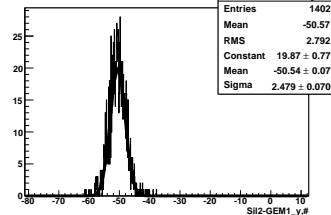
Sii1-GEM1_y



Sii2-GEM1_x



Sii2-GEM1_y



3D detector offsets

Determined Offsets

	x coordinate	y coordinate	$\langle z \rangle$ coordinate
GEM1	0.0 mm	0.0 mm	0.0 mm
GEM2	22.09 ± 0.01 mm	0.50 ± 0.09 mm	618.5 ± 0.5 mm
Sil1	38.39 ± 0.01 mm	51.33 ± 0.01 mm	85.4 ± 1.5 mm
Sil2	41.86 ± 0.09 mm	50.54 ± 0.07 mm	528.1 ± 1.5 mm

Inputs

- GEM1 is fixed as origin
- x and y offsets from delta plots
- z coordinates from photometry

Track fitting

Track model

- Straight tracks
- Neglect scattering
- Take all 4 detectors

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χ^2 Minimization

$$\chi^2 = N \sum_i |(\vec{f}(z_i) - \vec{\xi}_i)/\epsilon_i|^2,$$

with ϵ_i = detector pitch (error),
 $N = \sum_i \epsilon_i^2$, $f(z_i)$ calc. position,
 $\vec{\xi}_i$ measured position.

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Residuals

Distance between track and detector hit:

$$r_i^x = \vec{f}(z_i) \cdot \hat{e}_x - \vec{\xi}_i \cdot \hat{e}_x$$

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Biased residuals

4 det. tracking \rightarrow Too good

3 det. tracking \rightarrow Too bad

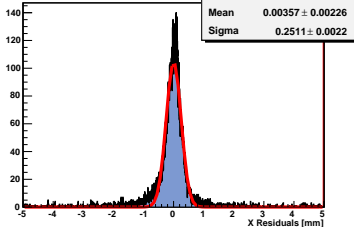
Take the geometric mean

\approx unbiased residuals

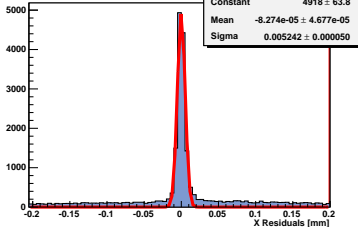
\rightsquigarrow detector resolution

Biased residuals

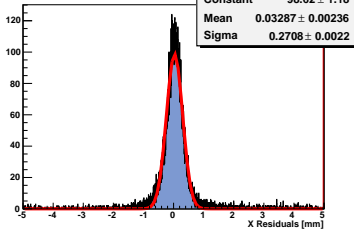
Residuals GEM1_X



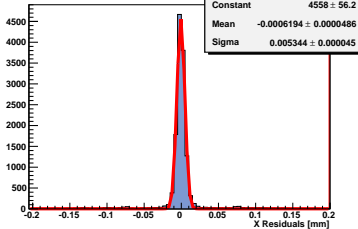
Residuals Si11_X



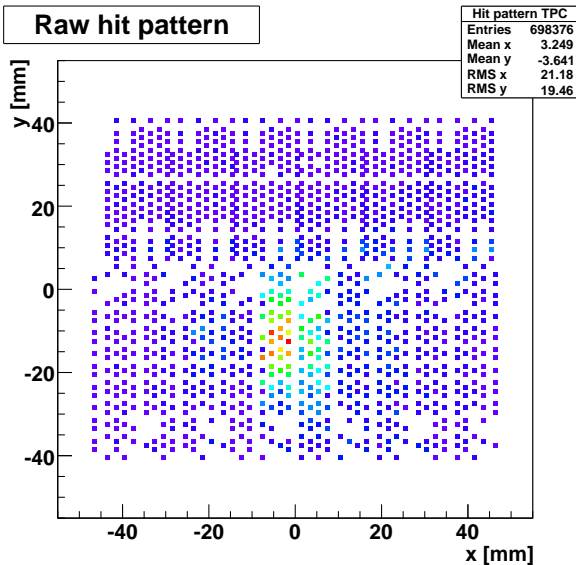
Residuals GEM2_X



Residuals Si12_X



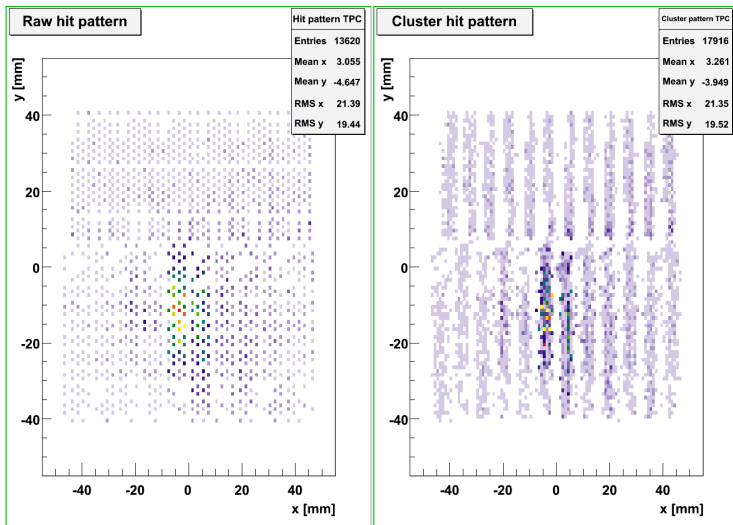
Hit pattern



Number of hits
above a 5σ
threshold.

Triggered beam
spot visible.

2D Clustering



Analysis of test TPC data

Done

- 2D clustering of hexagonal shapes
- Detector offsets determination
- TPC included in track fitting
- Generation of residual distributions

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Todo

- Investigate chip structure in cluster hit pattern
- Filter for correlated tracks
- Determine unbiased residual distribution

Summary

- Successful commissioning of beam telescope
- Development and application of tracking software
- Determination of biased residual distributions
- First results from test TPC obtained

Outlook

- Elaborate unbiased residuals
- Improve TPC clustering and residuals